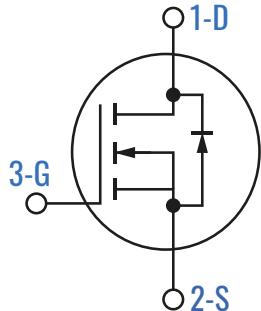


## KEY FEATURES

- $I_D$  15A
- $R_{DS(on)}$  760mΩ
- FAST RECOVERY DIODE
- AVALANCHE RATED
- TO-258 HERMETIC PACKAGE
- BACKSIDE ISOLATION
- JANTX, JANTXV SCREENING AVAILABLE



## ORDERING GUIDE

**Part Number** SMF404

**Description** 1000V N-Channel Power MOSFET

## ABSOLUTE MAXIMUM RATINGS ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	VALUE	TEST CONDITIONS
Drain-Source Voltage	$V_{DS(max)}$	1000V	$V_{GS} = 0\text{V}$ , $I_D = 100\mu\text{A}$
Gate-Source Voltage (dynamic)	$V_{GSM}$	$\pm 30\text{V}$	Transient
Gate-Source Voltage	$V_{GSS}$	$\pm 20\text{V}$	Continuous
Drain Current, continuous	$I_{D25}$	15A	$T_c = 25^\circ\text{C}$
Drain Current, pulsed	$I_{D(PULSE)}$	40A	Pulse width $T_p$ limited by $T_{Jmax}$
Power Dissipation	$P_D$	280W	$T_c = 25^\circ\text{C}$
Junction Temperature Range, Operating Junction Temperature Range, Storage	$T_J$ $T_{STG}$	-55°C to 150°C	

**ELECTRICAL SPECIFICATIONS ( $T_J = 25^\circ\text{C}$  unless otherwise noted)**

Parameter		Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 1\text{mA}$	$V_{(BR)DSS}$	1000			V
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1\text{mA}, T_J = 25^\circ\text{C}$	$V_{GS(\text{th})}$	3.5		6.5	V
Off -State Drain Current	$V_{DS} = 1000\text{V}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	$I_{DSS}$			25	$\mu\text{A}$
	$V_{DS} = 1000\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$				1	mA
Gate-Source Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$	$I_{GSS}$			$\pm 100$	nA
Drain-Source On-state Resistance	$V_{GS} = > 20\text{V}, I_D = 7.5\text{A}, T_J = 25^\circ\text{C}$	$R_{DS(on)}$		760	900	$\text{m}\Omega$
Transconductance	$V_{DS} = > 20\text{V}, I_D = 7.5\text{A}, T_J = 25^\circ\text{C}$	$G_{fs}$	6.5	8.5		S
Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 25\text{V}, f = 100\text{kHz}$	$C_{iss}$ $C_{oss}$ $C_{rss}$		5140 322 43		pF
Total Gate Charge Gate to Source Charge Gate to Drain Charge	$V_{GS} = 10\text{V}, V_{DS} = 0.5 \times V_{DSS}, I_{DS} = 0.5 \times I_{D25}$	$Q_{g(on)}$ $Q_{gs}$ $Q_{gd}$		97 38 42		nC
Turn On Delay Time Rx Time Turn Off Delay Time Fail Time	$V_{GS} = 10\text{V}, V_{DS} = 0.5 \times V_{DSS}, I_{DS} = 7.5 \times I_{D25}, R_G = 2\Omega$ (external)	$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$		41 44 44 58		ns
Thermal Resistance		$R_{thJC}$			0.445	$^\circ\text{C}/\text{W}$

**BODY DIODE CHARACTERISTICS ( $T_J = 25^\circ\text{C}$  unless otherwise noted)**

Parameter		Symbol	Min.	Typ.	Max.	Unit
Body Diode Forward Voltage	$I_F = I_S, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	$V_{SD}$			1.5	V
Body Diode Reverse Recovery Time	$V_r = 100\text{V}, V_{GS} = 0\text{V}, I_D = 7.5\text{A}, di/dt = 100\text{A}/\mu\text{s}$	$T_{rr}$			500	ns
Body Diode Reverse Recovery Charge	$I_F = 28\text{A}, di/dt = 100\text{A}/\mu\text{s}, V_R = 100\text{V}$	$Q_{RM}$		0.6		nC
Source to Drain Diode Current, cont.	$V_{GS} = 0\text{V}$	$I_S$			15	A
Pulse Diode Forward Current	Repetitive, pulse width limited by $T_{JM}$	$I_{SM}$			60	A

## TYPICAL PERFORMANCE

Fig. 1 Maximum Power Dissipation vs. Case Temperature

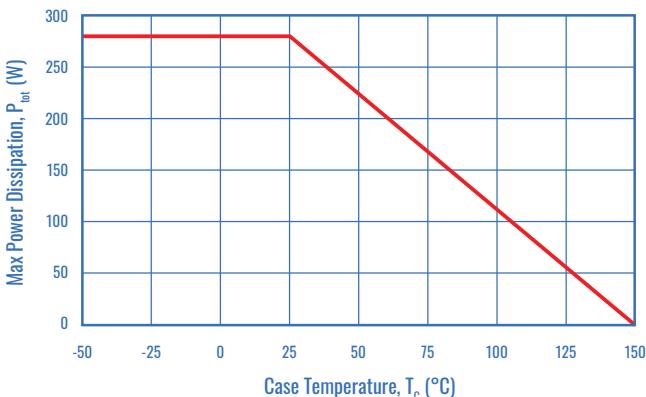


Figure 2. MOSFET Junction to case Transient Thermal Impedance, Z<sub>th</sub> J<sub>c</sub> (°C/W)

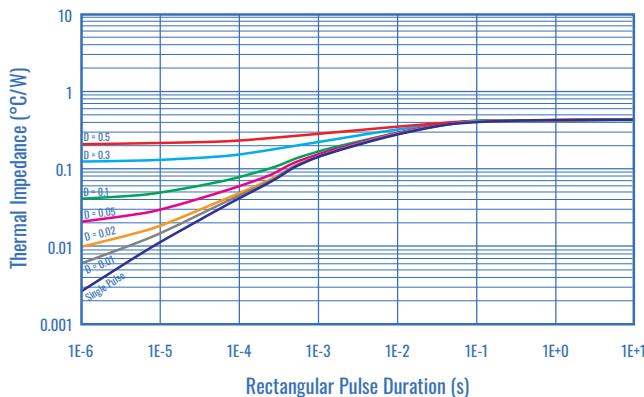
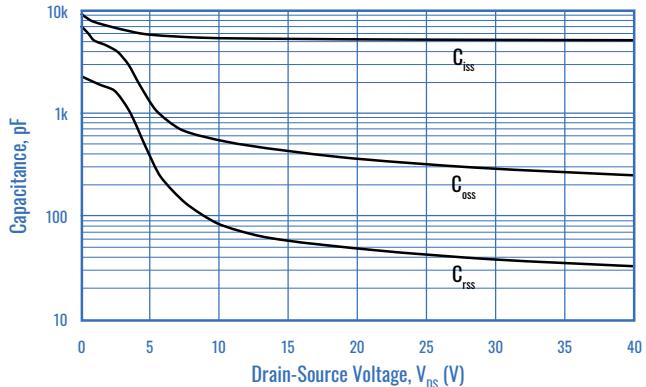
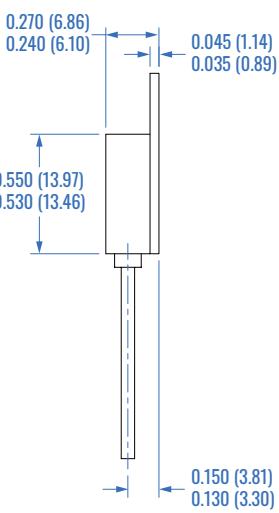
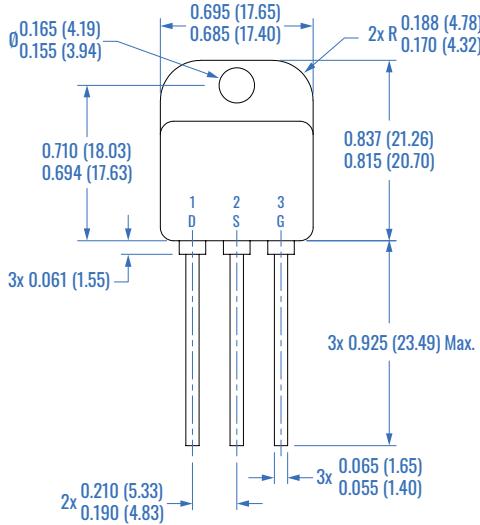


Figure 3. Capacitance vs Drain-Source Voltage



## OUTLINE DIMENSION



All dimensions in inches (mm)  
maximum  
minimum

## SCHEMATIC

